## Search Notes



Application/Control No.		

Applicant(s)/Patent Under Reexamination BEIER ET AL.

10582594 Examiner

Art Unit

Patrick F O'Reilly III

3749

## SEARCHED

Class	Subclass	Date	Examiner
454	71, 72, 76	7/28/2008	PFO3
62	172	7/28/2008	PFO3
Above	Updated	10/1/2009	PFO3
Above	Updated	2/2/2010	PFO3
454	74	2/3/2010	PFO3
244	118.5	2/3/2010	PFO3
165	235	2/3/2010	PFO3

## SEARCH NOTES

Search Notes	Date	Examiner		
EAST (USPAT, US-PGPUB, USOCR, EPO, JPO DERWENT, IBM_TDB)	7/27/2008;	PFO3		
searched - printout attached.	7/28/2008;			
	10/1/2009;			
	2/2/2010;			
	2/3/2010;			
	2/4/2010			
PLUS search performed - refer to search results in eDAN.	7/25/2008	STIC		
Inventor name search performed in PALM and EAST.	7/28/2008;	PFO3		
·	2/4/2010			

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
All Classes	Interference search performed - see attached printout	2/4/2010	PFO3